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Javier Hernández-Ferrer, Alejandro Ansón-Casaos, Sandra Víctor-Román, Olga Sanahuja-Parejo, Mª Teresa Martínez, Belén Villacampa, Ana M. Benito, Wolfgang K. Maser

aInstituto de Carboquímica ICB-CSIC, Miguel Luesma Castán 4, E-50018 Zaragoza, Spain
bDepartamento de Física de La Materia Condensada, ICMA, Universidad de Zaragoza-CSIC, E-50009, Zaragoza, Spain

*Corresponding author: E-mail: jhernandez@icb.csic.es; Tel.: +34 976 733977

Abstract

Nanostructured TiO₂ and graphene-based materials constitute components of actual interest in devices related to solar energy conversion and storage. In this work, we show that a thin layer of electrochemically reduced graphene oxide (ECrGO), covering nanostructured TiO₂ photoelectrodes, can significantly improve the photoactivity. In order to understand the working principle, ECrGO/TiO₂ photoelectrodes with different ECrGO thicknesses were prepared and studied by a set of photoelectrochemical measurements. Methanol in alkaline conditions was employed as effective hole acceptor probe to elucidate the electronic phenomena in the electrode layers and interfaces. These studies underline the hole accepting properties of ECrGO and reveal the formation of a p-n junction at the interface between ECrGO and TiO₂. It is shown for
the first time that the resulting space charge region of about 10 nm defines the
operational functionality of the ECrGO layer. Films thinner than the space charge
region act as hole transport layer (HTL), which efficiently transfers holes to the liquid
interface thus leading to enhanced photoactivity. Thicker films however act as hole
blocking layer (HBL), resulting in a systematic decrease of the photoactivity. The
finding of a thickness dependent threshold value for the operation of ECrGO as HTL
and HBL is of general interest for the fabrication of optoelectronic devices with
improved performance.

Keywords: titanium dioxide; reduced graphene oxide; photoelectrodes; hole-transport
layer; photoelectrochemistry

1. Introduction

Photoelectrochemistry is a powerful tool to elucidate the performance and working
mechanism of materials and interface components used in layered optoelectronic
devices, such as thin film solar cells. The resulting data reveal critical information about
electronic properties such as conduction and valence band limits, as well as trapping,
distribution, separation, recombination and transport of charges [1, 2]. Using a simple
electrochemical three-electrode configuration, photoelectrochemical measurements
enable the elucidation of processes occurring at the working electrode, covering
phenomena in bulk materials, across solid-solid interfaces for layered systems, as well
as across the solid-liquid interface. Importantly, the acquired information provides
valuable feedback for interface engineering towards optoelectronic device structures
with improved performance.
Materials of great current interest for solar energy conversion and storage are metal oxides such as ZnO [3] or TiO$_2$ [2], as well as carbon nanomaterials (graphene-based materials and carbon nanotubes) [4]. Employed as photoelectrodes [5], electron transport layers (ETLs) [6] or hole transport layers (HTLs) [7], they constitute important components in optoelectronic devices. Especially TiO$_2$, graphene, and their hybrid materials are widely studied for this purpose [2, 8-12]. In dye-sensitized solar cells, TiO$_2$ is often used as the active layer, working as a photoanode [13, 14]. In the case of perovskite [15] and organic solar cells [6], TiO$_2$ can constitute ETL [16, 17], enabling the transfer of photogenerated electrons from the photoactive material to the conducting substrate. In new generation solar cells, reduced graphene oxide (rGO) layers can act as electron or hole acceptors [18, 19], protective layers [18], layers to improve the adhesion between polymeric and oxide layers [20, 21], and sensitizers absorbing light in the visible region [22-26]. However, systematic studies on thickness effects to elucidate the working principle of thin layers of reduced graphene oxide are yet missing.

This work investigates the photoelectrochemical properties of nanostructured TiO$_2$ films covered with electrochemically reduced graphene oxide (ECrGO) layers of different thicknesses. The films are used as photoelectrodes in a three-electrode electrochemical cell. Methanol in an alkaline solution is used as effective probe (effective hole acceptor enabling the direct methanol photo-oxidation process) for elucidating the electronic processes across the solid-liquid and solid-solid interfaces of the working electrode. Cyclic voltammetry under dark and illuminated conditions, time-dependent photocurrent and photovoltage measurements, as well as electrochemical impedance
spectroscopy clearly reveal that ECrGO layers act as acceptors of photo-induced holes from TiO$_2$ resulting in the formation of a p-n junction at the interface between ECrGO and TiO$_2$ comprising a space charge region of about 10 nm. For ECrGO layers up to 10 nm in thickness, this region extends into the solid-liquid interface, enhancing the photoelectroactivity of the electrode, thus acting as hole transport layer (HTL). Contrariwise, for thicker ECrGO layers photo-generated holes cannot reach anymore the solid-liquid interface and get blocked. Hence ECrGO layers with higher thicknesses act as hole blocking layer (HBL). These findings give us, for the first time, a benchmark for the use of ECrGO as either HTL or HBL in order to achieve optoelectronic structures with improved performance.

2. Experimental and methods

2.1. Materials and equipment

Commercial TiO$_2$ nanoparticles (Aeroxide P25, Evonik) were used in this work. Graphite flakes were purchased from Aldrich (ref. 332461). Reagent grade NaOH was bought from Sigma Aldrich. Ethanol and isopropanol (p.a. grade) were obtained from Panreac. Methanol (analytical reagent grade) was acquired from Fisher Scientific. Soda lime glass substrates, coated with fluorinated tin oxide (FTO, 70-100 $\Omega$/sq, thickness of 80 nm, cut in 2.5x1 cm pieces) were shopped from Solems, Palaiseau, France. A graphite rod obtained from Cymit Quimica S.L., Barcelona, Spain, was used as the counter electrode. All the electrochemical measurements were performed in a three-electrode cell fitted with a quartz window, using an Autolab PGSTAT302N.
Illumination was carried out using a 150 W Xe arc lamp from LOT-Oriel (Germany), providing a measured light intensity of 300 mW·cm².

2.2 Electrode preparation

The electrode preparation process consists of 3 main stages: TiO₂ deposition, GO deposition, and GO electrochemical reduction (Figure S1, Supplementary data). First of all, FTO substrates were sonicated in isopropanol for 5 min. Blank TiO₂ films were prepared by spraying 1 mL of a TiO₂ suspension in absolute ethanol (2 mg/mL) onto approximately 1 cm² of the FTO substrate. Subsequently, the sample was thermally treated at 450°C for two hours in N₂ atmosphere. The resulting TiO₂ films were 1.3-1.5 µm thick, as determined with a profilometer (Bruker DektakXT Stylus).

GO was synthesized from graphite flakes by a modified Hummers method including the following stages: i) overnight treatment in NaNO₃/H₂SO₄/KMnO₄ at 35°C [27, 28], ii) cooling in 30% H₂O₂, iii) filtration, washing with diluted HCl and drying, and iv) resuspension in water at 0.5 mg·mL⁻¹ and exfoliation in an ultrasounds bath for 2 h, final oxygen content, as measured by XPS, was 30.3 % w/w.

GO was deposited onto TiO₂ films employing an automatized spray coater (Nadetech ND-SP, Pamplona, Spain). Four GO/TiO₂ electrodes were spray-coated from 1, 2, 5 and 15 mL of the GO dispersion aliquots, resulting in GO films of 5, 10, 20, and 60 nm, respectively. The GO films were electrochemically reduced applying four potentiodynamic cycles between -0.040 and -1.440 V vs. Hg/HgO 0.1M KOH [12, 29, 30] (Figure S2, Supplementary data) affording the final ECrGO/TiO₂ electrodes studied in this work, with an oxygen content of 17.7 %, determined by XPS, in the case of 60
6 nm ECrGO/TiO$_2$ electrode. The electrodes are translucent and allow for measurements in transmittance mode.

C1s XPS spectra for the initial GO material and the final electrode are shown in figure S2.

2.3. Physicochemical characterization

Scanning electron microscopy (SEM) studies were carried out with a Hitachi S3400 N. Atomic force microscopy (AFM) measurements were performed with a Multimode SPM from Veeco Instruments (Santa Barbara, US) equipped with Nanoscope V controller and J-scanner. Images were acquired in tapping mode using antimonium (n)-doped Si tips RTESPA PART MPP-11120. Roughness analysis was carried out using the Nanoscope Analysis Version 1.5 software (Veeco Ins). Optical absorption spectroscopy in the near ultraviolet-visible (UV-Vis) range was performed in transmittance mode using a Shimazdu UV-2401 PC spectrometer. Data representation in form of Tauc-plots with exponent 0.5 for indirect allowed transitions was used to determine the optical absorption edges. Absorption edges were corrected using the background absorption from 1.4 to 1.9 eV as baseline in order to compensate for scattering effects [31]. XPS measurements were performed in a ESCAPlus spectrometer (OMICRON GmbH, Germany) using a Mg anode (1253.6 eV) operating at 225W (15mA, 15kV). Valence band edges were determined as crossing point of the linear baseline with the fitted linear line of the low energy linear part of the valence band.

2.4. Photoelectrochemical measurements
All the (photo)electrochemical measurements were performed using N\textsubscript{2}-purged 0.1 M NaOH (pH=13) as the supporting electrolyte, to which 0.1 M methanol was added as hole acceptor, a Hg/HgO (0.1 M KOH) reference electrode and a graphite rod as the counter electrode. The scan rate was 20 mV·s\textsuperscript{-1} in all the cases. Two voltammetric cycles were performed, in order to achieve stationary conditions, and the second cycle is here presented. Photopotential was measured at zero current, according to $V_{ph} = E_{ph} - E_0$, where $E_{ph}$ and $E_0$ are the open circuit potential (OCP) with and without the xenon lamp illumination respectively. In addition, the net photocurrent density $j_{ph}$ is calculated from the voltammograms as the difference of the current density $j$ between light and dark conditions at approximately -0.1 V vs. Hg/HgO, 0.1M KOH. Potentiostatic on-off chronoamperometry was performed at 0.0 V (Hg/HgO, 0.1M KOH). Electrochemical impedance measurements were carried out from $10^5$ to $10^{-2}$ Hz at the respective OCPs under the xenon lamp irradiation.

3. Results and discussion

3.1. Physical characterization

Aeroxide® P25 TiO\textsubscript{2} is a well-described standard material [32], while a complete characterization of GO and rGO materials can be found in our previous works [27, 28, 33-35]. Surface topography and optical absorption response, features of direct concern to the performance of the ECrGO/TiO\textsubscript{2} photoelectrodes, are detailed in the following. An AFM image of the blank TiO\textsubscript{2} electrode (Figure 1A) shows a quite uniform porous structure for TiO\textsubscript{2} films, with aggregates of about 300-400 nm uniformly distributed on the surface. The porous structure is essentially maintained for 5 nm and 10 nm
ECrGO/TiO\textsubscript{2} layers (Figure 1B), although the aggregates seem to be larger than in blank TiO\textsubscript{2} (about 600 nm) and the surface is less homogeneous. For 60 nm ECrGO/TiO\textsubscript{2}, pore blocking due to the ECrGO layer thickness become evident (Figure 1C). The electrode surface is smoother than for blank TiO\textsubscript{2} and the spherical aggregates are not visible. In addition, AFM provides 3D quantitative information through the surface roughness parameters: \(S_a\) (average roughness evaluated over the complete 3D surface) and \(R_q\) (root mean square of height deviations taken from the mean image data plane (Table 1)). The \(S_a\) and \(R_q\) values are nearly identical for the blank TiO\textsubscript{2} and the 10 nm ECrGO/TiO\textsubscript{2} electrode, decreasing for electrodes with the thickest ECrGO layers. Finally the ECrGO layer becomes thick enough to block completely the porous structure of TiO\textsubscript{2}. All the AFM observations were confirmed by scanning electron microscopy images (Figure S3, Supplementary data). AFM and SEM results suggest the TiO\textsubscript{2} surface is almost entirely covered by ECrGO, and thus, the solid/liquid interface will be mainly constituted between ECrGO and the electrolyte. These results are in agreement with SEM observations (Figure S3, Supplementary data).

The optical properties of the translucent ECrGO/TiO\textsubscript{2} photoelectrodes were analyzed by UV-Vis spectroscopy in transmittance mode (Figure S4, Supplementary data). A Tauc-plot representation of the acquired spectra is shown in Figure 2, The TiO\textsubscript{2} electrode reveals an absorption peak at 3.9 eV, and an absorption edge at 3.20 eV, (Figure 2) in agreement with the literature value for the indirect bandgap of TiO\textsubscript{2} [36]. In ECrGO/TiO\textsubscript{2} electrodes, both the absorption peak and the edge shift to lower energies with respect to the blank TiO\textsubscript{2} electrode. The lowest value of the absorption edge (2.70 eV) corresponds to the 5 nm ECrGO/TiO\textsubscript{2} electrode, and it subsequently increases with the thickness of the deposited ECrGO film (Table S1, Supplementary data).
While effects related to scattering from TiO$_2$ or the absorption from ECrGO are discarded as reasons for the observed shifts of the absorption edges, (see experimental details, as well as Supplementary data on Transmittance spectra, Figure S4), ECrGO layers most likely introduce a surface modification that strongly affects the electronic interactions between the ECrGO and TiO$_2$ interface. This may involve charge-transfer or/and space charge phenomena being responsible for the observed thickness dependent changes of the absorption levels of the nanostructured semiconducting electrodes [11, 23, 37, 38], as will be discussed in more detail in section 3.2.

On the other hand, valence band XPS spectra (Figure 3) show no change in the position and structure of TiO$_2$ valence band. These results indicate that the optical absorption properties (Figure 2), involve almost exclusively electronic levels close to the one of the conduction band of TiO$_2$.

3.2 Cyclic Voltammetry

3.2.1 Dark Voltammograms

An electrochemical study under dark conditions was performed for the description of the electrode interfaces in equilibrium state. In agreement with previous literature works [2], the dark voltammogram for the TiO$_2$ electrode in the supporting electrolyte exhibits an accumulation region at potentials lower than -1.1 V, a small feature due to electronic trap states at -0.7 V, and a depletion region at higher potentials (Figure 4). The ECrGO/TiO$_2$ electrodes show three significant changes compared to blank TiO$_2$:
• The accumulation region is shifted towards negative potentials (Figure 4B), reflecting an increase in the apparent energy of the conduction band edge, due to a negative charge accumulation in TiO$_2$. According to literature [39], this effect is assigned to an increase in the number of occupied Ti(III) states. Consequently, in ECrGO/TiO$_2$ electrodes, ECrGO would constitute a positively charged layer, thus, increasing the negative charge on TiO$_2$ surface [2, 11, 40]. The increase of their electron density through an effective charge transfer, thus shifts the measured conduction band edge towards more negative potentials[39, 40]. This charge separation between ECrGO and TiO$_2$, also predicted using ab-initio calculations [23, 41], constitutes the first evidence of the formation of a p-n junction between TiO$_2$ and ECrGO.

• A redox feature centered at -0.9 V increases with the rGO thickness until a nearly constant charge density (15, 20, 60 and 66 $\mu$C·cm$^{-2}$ for the 5, 10, 20 and 60 nm ECrGO/TiO$_2$ electrodes, respectively; Figure S5A, Supplementary data). It can be assigned to electron trapping [42] at the interface between TiO$_2$ and ECrGO.

• An increase in the capacitive current takes place in the depletion region (E > -0.9 V), which is ascribed to an increase in the electrochemical capacitance due to the presence of ECrGO in contact with the electrolyte (Figure S5B, Supplementary data).

Next, changes taking place in the system upon the addition of methanol will be considered. Its value as effective probe for elucidating the electronic processes across
the solid-liquid and solid-solid interfaces will be discussed in the following sections.

Figure 5A shows cyclic voltammetry measurements for the ECrGO/TiO$_2$ electrodes, before and after the addition of 0.1 M methanol. Blank TiO$_2$ experiences a negative shift in the accumulation region, demonstrating the adsorption of methanol and its role as electron donor to TiO$_2$. On the contrary, a large positive shift (140 mV) is observed for the 5 nm ECrGO/TiO$_2$ electrode, which is an indication of a strong interaction between methanol and ECrGO. Methanol is adsorbed as electron donor (or hole acceptor) on ECrGO [43], thus decreasing the quantity of positive charge in the layer, and consequently the electron transfer to the TiO$_2$ layer underneath, causing a displacement of the observed conduction band level towards positive potentials[40, 44]. The positive shift decreases for the 10 nm ECrGO/TiO$_2$ electrode (60 mV), and finally it almost disappears for the 20 nm ECrGO/TiO$_2$ electrode (10 mV), showing that, beyond a given film thickness, charge separation across the TiO$_2$/ECrGO interface is much less efficient.

The observed thickness effect is related to the spatial extension of the space charge built-up at the interface between the ECrGO and the TiO$_2$ layer. Its width can be estimated using equation (1), typically employed for p-n junctions [45]:

$$W_{sc} = \sqrt{\frac{2\phi e}{\epsilon N_D}}$$  \hspace{1cm} (1)$$

where $W_{sc}$ is the width of the space charge layer, $\phi$ is the potential drop across the interface between ECrGO and electrolyte (or TiO$_2$), $e$ is the elementary charge and $N_D$ is the carrier concentration. Typically, $W_{sc}$ for graphite is 1 nm (three atomic layers) [45]. Taking then into account that the measured through-plane permittivity is 25 times
higher for rGO than for graphite [46], and $N_D$ is typically 3-4 times higher for graphene than for rGO ($10^{13}$ [47] vs. $3 \times 10^{12}$ [48]), one can roughly estimate the space charge layer thickness of ECrGO to be in the range from 8 to 10 nm. Although being a very rough first approximation, it reveals that for our thinnest ECrGO coatings, the, space charge layer thickness is larger than the ECrGO layer thickness itself. Consequently, the space charge width for ECrGO layers of 5 to 10 nm in thickness extends into the adjacent external interface layer (i.e. the adsorbed methanol) and thus favorably influences on the photoelectrochemical properties, as discussed in section 3.2.2. On the contrary, for ECrGO layers with thicknesses beyond 10 nm, the space charge width remains within the ECrGO layer, resulting in a decreased photoactivity.

Finally, Trap states at ~ 0.9 V shift in the presence of methanol, following a trend analogous to the conduction band edge.

A semi-quantitative calculation of the lowest energy level of the TiO$_2$ conduction band can be performed from the voltammetry measurements. The conduction band positions for the ECrGO/TiO$_2$ electrodes were calculated as the relative differences between linear regions in a plot of log($C$) vs. $E$, where the capacitance per surface area is determined as $C=j \cdot (scan\ rate)^{-1}$ (Table S1, and Figures S5B and S6B, Supplementary data) [40]. In order to obtain an absolute value for the band edges, the position of blank TiO$_2$ in methanol was set to -1.40 V vs. Hg/HgO 0.1M KOH, according to a literature value [2]. In this way, a comparative graph for the conduction band edge is constructed for the ECrGO/TiO$_2$ electrodes in the presence of methanol (Figure 5B). The TiO$_2$ conduction band shifts to less negative potentials in the 5 nm ECrGO/TiO$_2$ electrode
compared to the TiO$_2$ electrode. However, as the thickness increases, the conduction band edge, systematically, goes again to more negative potentials, following a clear trend. This, once more, clearly underlines the importance of the thickness of the ECrGO layers for the overall electrochemical performance of the ECrGO/TiO$_2$ electrodes.

3.2.2. Photoelectrochemistry under illumination in the presence of methanol

Figure 6A shows cyclic voltammetry measurements in the presence of methanol. The steep increase in the current corresponds to methanol photo-oxidation. A half wave potential $E_{1/2}$ can be defined as the potential required for reaching a half of the maximum photocurrent density $j_{ph}$. The $E_{1/2}$ values are listed in Table 2, together with $j_{ph}$. The $E_{1/2}$ for 5 nm ECrGO/TiO$_2$, 10 nm ECrGO/TiO$_2$ and 20 nm ECrGO/TiO$_2$ are lower than for the bare TiO$_2$ electrode. An increase in the $j_{ph}$ of 14% and 9% is obtained for the 5 and 10 nm ECrGO/TiO$_2$ electrodes respectively. When ECrGO layers become thicker, $j_{ph}$ starts to decrease with film thickness, and it is almost completely blocked in the 60 nm ECrGO electrode. Only in thin ECrGO/TiO$_2$ electrodes, photogenerated holes are efficiently transferred from TiO$_2$ to the valence band of ECrGO layer, in agreement with its behavior as hole acceptor observed in section 3.2.1. Methanol in solution is able to capture photo-holes, providing an electron to ECrGO, and improving $j_{ph}$ and $E_{1/2}$ compared to TiO$_2$. When performing potentiostatic on-off photocurrent measurements at 0.0 V (Figure 6B), it can be observed that the photocurrent is rather stable with time. However, the stability gets further improved due to the presence of the ECrGO layers, in agreement with observations for GO and rGO in solar energy systems [6, 18]. Photocurrent decreases from $j_{(t=15s)} = 136 \, \mu A \cdot cm^{-2}$ to $j_{(t=290s)} = 129 \, \mu A \cdot cm^{-2}$ (5.1%) in the case of TiO$_2$, and from $j_{(t=15s)} = 151 \, \mu A \cdot cm^{-2}$ to $j_{(t=290s)} = 149 \, \mu A \cdot cm^{-2}$ (1.3%) in the
case of 5 nm ECrGO/TiO$_2$ electrode, remaining essentially constant for 10 nm ECrGO/TiO$_2$ electrode. At $t=290$ s, the increase in photocurrent, with respect to the TiO$_2$ electrode, is 16% for 5 nm ECrGO/TiO$_2$ and 11% for 10 nm ECrGO/TiO$_2$.

The increase in halfwave potential and photocurrent implies improved charge separation and, once more, suggests the formation of a p-n junction, as also described in the literature for similar TiO$_2$/rGO systems [22, 49]. In these systems, photoelectrons remain in TiO$_2$, while photoholes move to rGO (ECrGO in our case). As rGO is in contact with the solution, the holes are more likely to be transferred to the molecules of the liquid phase. The formation of a p-n junction has been observed to provide a significant decrease in the onset potential for water photooxidation, not only for rGO films, but also with inorganic semiconductor layered systems, such as CoO$_x$/TiO$_2$ [50, 51], TiO$_2$/hematite [52, 53] and WO$_3$/FeOOH [54] electrodes.

In agreement with previous reports, the photocurrent for methanol oxidation is higher than for water oxidation [55]. Actually, although the halfwave potential is more negative, the water oxidation photocurrent in ECrGO/TiO$_2$ electrodes decreases compared to blank TiO$_2$, indicating that water molecules do not efficiently react with photogenerated holes, most probably due to the hydrophobic nature of graphene basal plane [56] (Figure S7 and Table S2, Supplementary data). Therefore, when ECrGO forms part of the electrode-solution interface, the interaction between water and ECrGO active sites is not efficient to favor charge transport towards the liquid phase. On the contrary, when methanol is present in the solution, strong interactions with the electrode surface are achieved [56-58] and an improvement in both the halfwave potential and the photocurrent is obtained.
As can be seen from these results key issues for achieving improved photoactivity in layered ECrGO/TiO$_2$ photoelectrodes refer to: (a) the formation of favorable solid-liquid interface interactions (provided by methanol acting as hole acceptor), (b) the establishment of a p-n junction at the solid-solid interface between the hole-accepting ECrGO and the TiO$_2$ layers, and a corresponding space charge region which extends into the adjacent solid-liquid interface and thus enables effective hole transport to the neighboring hole-accepting (methanol) layer. This is ensured whenever ECrGO thickness < $W_{sc}$ thickness. This threshold criterion is responsible for the observed thickness effects.

3.3 Photopotential measurements

Open circuit potential (OCP) in the dark provides an estimation of the Fermi level energy of the electrode and, in the absence of any reversible redox couple, it is determined kinetically by all the processes occurring at the electrode [2]. For ECrGO/TiO$_2$ electrodes in 0.1 M NaOH + 0.1 M methanol, the OCP in the dark is higher than for TiO$_2$, indicating that the combined effects of methanol and ECrGO layers decrease the electron energy in the system.

Figure 7 shows the evolution of OCP during 3 min. The electrodes are exposed to xenon lamp irradiation for 50 s, and then the lamp is switched off. The photopotential is defined as the difference between OCPs under illumination and initial in the dark ($V_{ph}=E_{ph}-E_0$), and it is directly related to the quantity of photogenerated electron-hole pairs. The value of $E_{ph}$ for a photoanode is associated to the excess of electrons in the
conduction band, while holes are transferred to the solution, and it is only limited by the energy level of the conduction band [2]. The measured $E_{\text{ph}}$ and $V_{\text{ph}}$ values are listed in Table 2. For the 5 nm ECrGO/TiO$_2$ electrode, $E_{\text{ph}}$ is 5% less negative and $V_{\text{ph}}$ is 44% higher with respect to blank TiO$_2$. Therefore, a higher quantity of electron-hole pairs is separated. For 10 and 20 nm ECrGO/TiO$_2$ electrodes, $V_{\text{ph}}$ and $E_{\text{ph}}$ are also higher (in absolute values) than the respective values for TiO$_2$. Moreover, the 20 nm ECrGO/TiO$_2$ electrode shows the highest $V_{\text{ph}}$. However, it needs the longest time to reach a stationary $E_{\text{ph}}$ value, i.e. the processes that govern photoactivity are slow, and thus a decrease in the $j_{\text{ph}}$ is observed. For 60 nm ECrGO/TiO$_2$, the processes are so slow that no stationary photopotential is reached in the time range. These results further underline that ECrGO layers act as hole acceptors from TiO$_2$ and thus efficiently contribute to improved charge separation. For thin films holes can be transferred to the subsequent hole acceptor molecule (i.e. methanol) leading to enhanced photoactivity. In this situation ECrGO assumes the function of a hole transport layer (HTL). For thick films holes get blocked in the ECrGO layer, and photoactivity decreases with film thickness. Under this circumstance, ECrGO plays the role of a hole-blocking layer (HBL). The overall mechanism is summarized in Scheme 1.

3.4 Electrochemical Impedance Spectroscopy

Potentiostatic impedance spectra in 0.1 M NaOH + 0.1 M methanol were performed at the respective OCPs under illumination for the 5 nm, 10 nm and 20 nm ECrGO/TiO$_2$ electrodes, as well as for the bare TiO$_2$ electrode (Figure 8), and fitted to the equivalent circuit shown in Figure S7, commonly used for the description of the behavior of semiconductor electrodes [59]. The impedance spectra for TiO$_2$ and ECrGO/TiO$_2$ are
qualitatively similar, and fit to the same equivalent circuit. This suggests that the electrode/solution interface is only constituted by one single component, whereby essentially only ECrGO is in contact with the solution, in agreement with SEM and AFM results. Areas of non-covered TiO$_2$ eventually may be in direct contact with the solution, but their influence is estimated to be negligible. The modulus Bode plot is shown in Figure 8A and the phase Bode plot is in Figure 8B. At intermediate frequencies around $10^2$ Hz, a small feature appears in all the samples, which can be tentatively ascribed to the FTO exposed to the electrode (charge transfer resistance R1, in parallel with capacitance Q1, of FTO exposed zones[60]). At low frequencies, the phase Bode plot for the TiO$_2$ electrode shows a peak centered at 0.08 Hz, which describes the intrinsic behavior of the film (charge-transfer resistance R2 in parallel with the chemical capacitance of the film Q2, see Figure S8, Supplementary Data, and [1, 60]). The peak shifts for the ECrGO/TiO$_2$ films, indicating changes in the total capacitance of the film (Table S3, Supplementary data). Impedance modulus for 5 nm and 10 nm ECrGO/TiO$_2$ is higher than impedance modulus for TiO$_2$ at frequencies higher than 0.1 Hz. On the contrary, at lower frequencies, impedances for 5 nm ECrGO (1.2·$10^4$ $\Omega$) and 10 nm ECrGO/TiO$_2$ (4.6·$10^3$ $\Omega$) electrodes are significantly lower than for TiO$_2$ (2.6·$10^4$ $\Omega$). The decrease in the impedance modulus is associated with low phase angles, thus indicating that charge transfer at the electrode is much faster for TiO$_2$ electrodes covered with thin ECrGO layers, in agreement with the findings described above. For rGO layers as thick as 20 nm, the positive effect is lost. The 10 nm ECrGO/TiO$_2$ electrode presents the best charge transfer properties (the lowest impedance) among the studied materials. The low value of OCP under illumination ($E_{ph}$) (Section 3.3) plays a key role and leads to a clear improvement in the TiO$_2$ behavior as the photoanode of photocatalytic and photovoltaic systems.
4. Conclusions

Photoelectrochemical measurements in the presence of methanol show that a thin ECrGO covering layer significantly improves the photopotential (up to 270 mV), halfwave potential (up to 120 mV) and photocurrent (up to ca. 16%) of nanostructured TiO$_2$ electrodes. These results reveal that the mechanism behind this process is based on (a) the formation of a favorable solid-liquid interface. This is ensured by the use of methanol as well adsorbing hole acceptor; (b) the establishment of a p-n junction at the solid-solid interface between the hole-accepting ECrGO coating layer and the TiO$_2$ layer underneath. Here the width of the built-up space charge region of about 10 nm defines a clear threshold criterion for the operational functionality of the ECrGO coating layer and the photoactivity of the overall ECrGO/TiO$_2$ photoelectrode. For ECrGO layers with thicknesses smaller than the width of the space charge region, the space charge region extends into the solid-liquid interface. This favors hole-transport to hole accepting methanol resulting in enhanced photoactivity of the photoelectrode. In this scenario ECrGO acts as hole transport layer (HTL) When the thickness of the ECrGO coating layer exceeds the width of the space charge region holes get blocked in the ECrGO layer leading to a decreased photoactivity. Here ECrGO acts as hole blocking layer (HBL). These findings for the first time establish a general criterion for the use of (electrochemically) reduced graphene oxide as either HTL or HBL as component in layered optoelectronic device structures thus being of general relevance for the fabrication of devices with improved performance.
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Crystalline composition analysis, reconstruction from isolated pure particles and

Graphene Oxide Chemistry via Spatially-Resolved Electron Energy Loss Spectroscopy,

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Dioxide/Aqueous Solution Interface: Approximate Conduction Band Edge Variations


### Table 1. Roughness parameters calculated from AFM data.

<table>
<thead>
<tr>
<th>Electrode</th>
<th>$S_q$/nm</th>
<th>$S_a$/nm</th>
</tr>
</thead>
<tbody>
<tr>
<td>TiO$_2$</td>
<td>240</td>
<td>177</td>
</tr>
<tr>
<td>10 nm ECrGO/TiO$_2$</td>
<td>257</td>
<td>180</td>
</tr>
<tr>
<td>60 nm ECrGO/TiO$_2$</td>
<td>185</td>
<td>145</td>
</tr>
</tbody>
</table>

### Table 2. Photoactivity parameters in 0.1 M NaOH + 0.1 M methanol.

<table>
<thead>
<tr>
<th>Electrode</th>
<th>$E_{1/2}$/V</th>
<th>$j_{ph}$/µA·cm$^{-2}$</th>
<th>$E_{ph}$/V</th>
<th>$V_{ph}$/V</th>
</tr>
</thead>
<tbody>
<tr>
<td>TiO$_2$</td>
<td>-0.97</td>
<td>136</td>
<td>-1.21</td>
<td>-0.61</td>
</tr>
<tr>
<td>5 nm ECrGO/TiO$_2$</td>
<td>-1.04</td>
<td>154</td>
<td>-1.15</td>
<td>-0.88</td>
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<tr>
<td>10 nm ECrGO/TiO$_2$</td>
<td>-1.09</td>
<td>148</td>
<td>-1.25</td>
<td>-0.85</td>
</tr>
<tr>
<td>20 nm ECrGO/TiO$_2$</td>
<td>-1.06</td>
<td>86</td>
<td>-1.25</td>
<td>-0.92</td>
</tr>
<tr>
<td>60 nm ECrGO/TiO$_2$</td>
<td>-0.99</td>
<td>3</td>
<td>-</td>
<td>-</td>
</tr>
</tbody>
</table>
**Figure 1.** 35x35 µm AFM images of different electrodes: A) TiO$_2$, B) 10 nm ECrGO/TiO$_2$, and C) 60 nm ECrGO/TiO$_2$. 
Figure 2. Tauc plot for the TiO$_2$ and ECrGO/TiO$_2$ electrodes.

Figure 3. Valence band XPS spectra for the TiO$_2$ and ECrGO/TiO$_2$ electrodes.
Figure 4. Cyclic voltammetry in dark conditions (0.1 M NaOH, v=20 mV·s⁻¹): A) Blank TiO₂ indicating the voltammogram main regions; and B) TiO₂ compared to the ECrGO/TiO₂ electrodes with the thinnest ECrGO films.
Figure 5. Electrochemical characterization in dark conditions for the TiO$_2$ and ECrGO/TiO$_2$ electrodes: A) Cyclic voltammetry in 0.1 M NaOH and 0.1 M NaOH + 0.1 M methanol ($v=20$ mV·s$^{-1}$); and B) approximate position of the TiO$_2$ conduction band.
Figure 6. (A) Cyclic voltammograms (anodic sweep) at 20 mV·s\(^{-1}\) under illumination and (B) chronoamperograms at 0.4 V for the TiO\(_2\) and ECrGO/TiO\(_2\) electrodes in 0.1 M NaOH + 0.1 M MeOH.
Figure 7. Photopotential measurements for the TiO$_2$ and ECrGO/TiO$_2$ electrodes in 0.1 M NaOH + 0.1 M methanol.
Figure 8. Electrochemical impedance spectroscopy for the TiO$_2$ and ECrGO/TiO$_2$ electrodes under illumination in 0.1 M NaOH + 0.1 M methanol: A) impedance modulus Bode plot, and B) phase Bode plot. Measurements were performed at the respective OCP: -1.31 V for TiO$_2$, -1.06 V for 5 nm ECrGO/TiO$_2$, -1.13 V for 10 nm ECrGO/TiO$_2$, and -1.22 V for 20 nm ECrGO/TiO$_2$. 
Scheme 1. Interpretation of the photocatalytic mechanism of methanol oxidation on ECrGO/TiO$_2$ electrodes: A) in the dark, partial negative charges ($\delta^-$) accumulate on TiO$_2$, and partial positive charges ($\delta^+$) accumulate on ECrGO. Under illumination, electrons and holes are generated at TiO$_2$, and photo-holes are transferred to ECrGO; B) if the ECrGO layer is thinner than the space charge layer, the hole is able to react with methanol and the ECrGO layer acts as a hole-transport layer; C) if the ECrGO layer is thicker than the space charge layer, the hole cannot reach the solution and ECrGO acts as a blocking layer.